

标题: Terahertz detection using spectral domain interferometry

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来源出版物: OPTICS LETTERS 卷: 37 期: 20 页: 4338-4340 出版年: OCT 15 2012

在 Web of Science 中的被引频次: 0

被引频次合计: 0

引用的参考文献数: 14

摘要: In this work, we present a novel method based on spectral domain interferometry for the electro-optic (EO) sampling of terahertz (THz) electric fields. This technique allows the use of thick crystals without the drawback of the over-rotation that may occur with intense THz sources, allowing longer temporal scans and thus, better spectral resolution. Using this technique, a phase difference of approximately  $8898\pi$  can be measured, which is 18,000 times larger than the phase difference that could be measured using EO sampling. (C) 2012 Optical Society of America

入藏号: WOS:000310052800058

语种: English

文献类型: Article

KeyWords Plus: PULSE; THZ

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出版商: OPTICAL SOC AMER

出版商地址: 2010 MASSACHUSETTS AVE NW, WASHINGTON, DC 20036 USA

Web of Science 类别: Optics

研究方向: Optics

IDS 号: 023RP

ISSN: 0146-9592

29 字符的来源出版物名称缩写: OPT LETT

ISO 来源出版物缩写: Opt. Lett.

来源出版物页码计数: 3